

September 2001

# **FDFS2P103**

# Integrated P-Channel PowerTrench® MOSFET and Schottky Diode

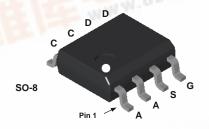
## **General Description**

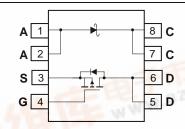
The FDFS2P103 combines the exceptional performance of Fairchild's PowerTrench MOSFET technology with a very low forward voltage drop Schottky barrier rectifier in an SO-8 package.

This device is designed specifically as a single package solution for DC to DC converters. It features a fast switching, low gate charge MOSFET with very low onstate resistance. The independently connected Schottky diode allows its use in a variety of DC/DC converter topologies.

#### **Features**

- -5.3 A, -30V  $R_{DS(ON)} = 59 \text{ m}\Omega$  @  $V_{GS} = -10 \text{ V}$  $R_{DS(ON)} = 92 \text{ m}\Omega$  @  $V_{GS} = -4.5 \text{ V}$
- V<sub>F</sub> < 0.52 V @ 1 A (T<sub>J</sub> = 125°C)
   V<sub>F</sub> < 0.57 V @ 1 A (T<sub>J</sub> = 25°C)
- Schottky and MOSFET incorporated into single power surface mount SO-8 package
- Electrically independent Schottky and MOSFET pinout for design flexibility





# Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter Parameter Parameter		Ratings	Units
V <sub>DSS</sub>	MOSFET Drain-Source Voltage		-30	V
V <sub>GSS</sub>	MOSFET Gate-Source Voltage		±25	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	-5.3	А
	- Pulsed		-20	- 12/1
P <sub>D</sub>	Power Dissipation for Dual Operation		2	W
	Power Dissipation for Single Operation	(Note 1a)	1.6	ZSC-U
		(Note 1b)	1 WWW.	
		(Note 1c)	0.9	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperation	ture Range	-55 to +150	°C
$V_{RRM}$	Schottky Repetitive Peak Reverse Voltage	9	30	V
Io	Schottky Average Forward Current	(Note 1a)	1	Α

## Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity	
FDFS2P103	FDFS2P103	13"	12mm	2500 units	



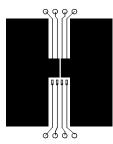
BV <sub>DSS</sub> <u>ABVDSS</u> <u>ATJ</u> I <sub>DSS</sub> I <sub>GSSF</sub> I <sub>GSSR</sub>	Drain-Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage, Forward Gate-Body Leakage, Reverse		$I_D = -250 \mu\text{A}$ eferenced to 25°C	-30	-23		l v
ΔBVDSS ΔTJ IDSS IGSSF IGSSR	Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate–Body Leakage, Forward	$I_D = -250 \mu\text{A}, \text{Re}$ $V_{DS} = -24 \text{V},$	eferenced to 25°C	-30	22		V
ΔT <sub>J</sub> I <sub>DSS</sub> I <sub>GSSF</sub> I <sub>GSSR</sub>	Coefficient Zero Gate Voltage Drain Current Gate–Body Leakage, Forward	$V_{DS} = -24 \text{ V},$			22		
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	_			-23		mV/°C
I <sub>GSSR</sub>	, ,	$V_{GS} = 25 \text{ V},$	$V_{GS} = 0 V$			-1	μΑ
	Gate-Body Leakage, Reverse		$V_{DS} = 0 V$			100	nA
On Char		$V_{GS} = -25 \text{ V},$	$V_{DS} = 0 V$			-100	nA
	acteristics (Note 2)	•			•		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$	$I_D = -250  \mu A$	-1	-1.7	-3	V
$\Delta V_{GS(th)}$ $\Delta T_J$	Gate Threshold Voltage Temperature Coefficient		eferenced to 25°C		4.5		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = -10 \text{ V},$ $V_{GS} = -4.5 \text{ V},$ $V_{GS} = -10 \text{ V}, I_D =$			46 70 63	59 92 88	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -10 \text{ V},$		-20			Α
<b>g</b> FS	Forward Transconductance	$V_{DS} = -5V$ ,			10		S
Dvnamic	Characteristics	•			1	ı	
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -15 \text{ V},$	$V_{GS} = 0 V$ ,		528		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		132		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance				70		pF
Switchin	q Characteristics (Note 2)	•			•		
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -15 \text{ V},$	$I_{D} = -1 A,$		7	14	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = -10 \text{ V},$	$V_{GS} = -10 \text{ V},  R_{GEN} = 6 \Omega$				ns
t <sub>d(off)</sub>	Turn-Off Delay Time			14	25	ns	
t <sub>f</sub>	Turn-Off Fall Time				9	17	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = -15 \text{ V},$	$I_D = -5.3 \text{ A},$		5.3	8	nC
$Q_{gs}$	Gate-Source Charge	$V_{GS} = -5 \text{ V}$			2.2		nC
$Q_{gd}$	Gate-Drain Charge				1.6		nC
Drain-So	ource Diode Characteristics	and Maximum	Ratings		•		
Is	Maximum Continuous Drain-Source					-1.3	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_{S} = 0 \text{ V}$	= -1.3 A (Note 2)		-0.7	-1.2	V
Schottky	Diode Characteristics						
I <sub>R</sub>	Reverse Leakage	$V_{R} = 30 \text{ V}$	$T_J = 25^{\circ}C$		15	100	μΑ
.,		1	T <sub>J</sub> = 125°C		6	30	mA
$V_F$	Forward Voltage	$I_F = 1A$	$T_J = 25^{\circ}C$ $T_J = 125^{\circ}C$		0.41	0.57 0.52	V

## **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	135	°C/W
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

#### Notes:

R<sub>8JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of
the drain pins. R<sub>8JC</sub> is guaranteed by design while R<sub>8CA</sub> is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in² pad of 2 oz copper



125°C/W when mounted on a 0.02 in<sup>2</sup> pad of 2 oz copper



135°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

**2.** Pulse Test: Pulse Width <  $300\mu s$ , Duty Cycle < 2.0%

# **Typical Characteristics**

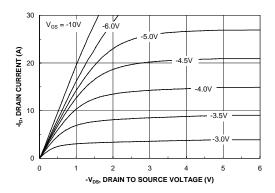


Figure 1. On-Region Characteristics.

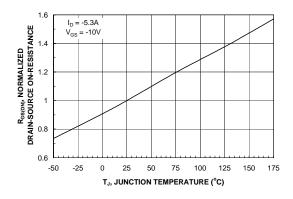


Figure 3. On-Resistance Variation with Temperature.

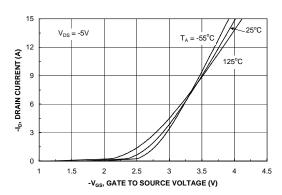


Figure 5. Transfer Characteristics.

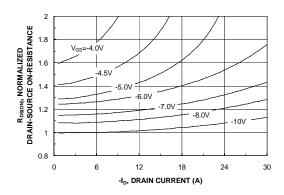


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

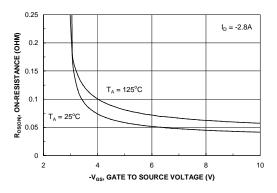


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

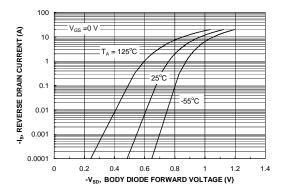
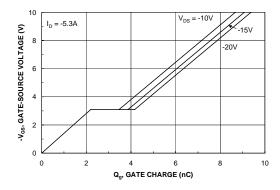


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics**



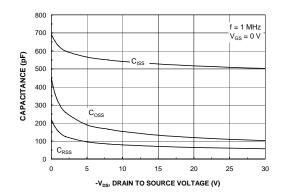


Figure 7. Gate Charge Characteristics.

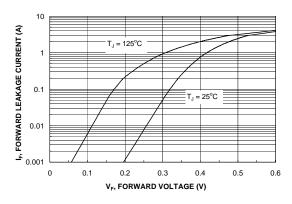


Figure 8. Capacitance Characteristics.

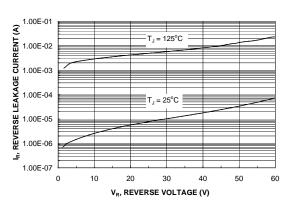


Figure 9. Schottky Diode Forward Voltage.



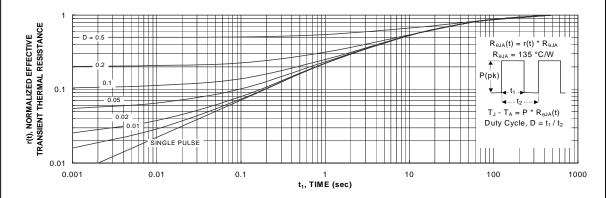
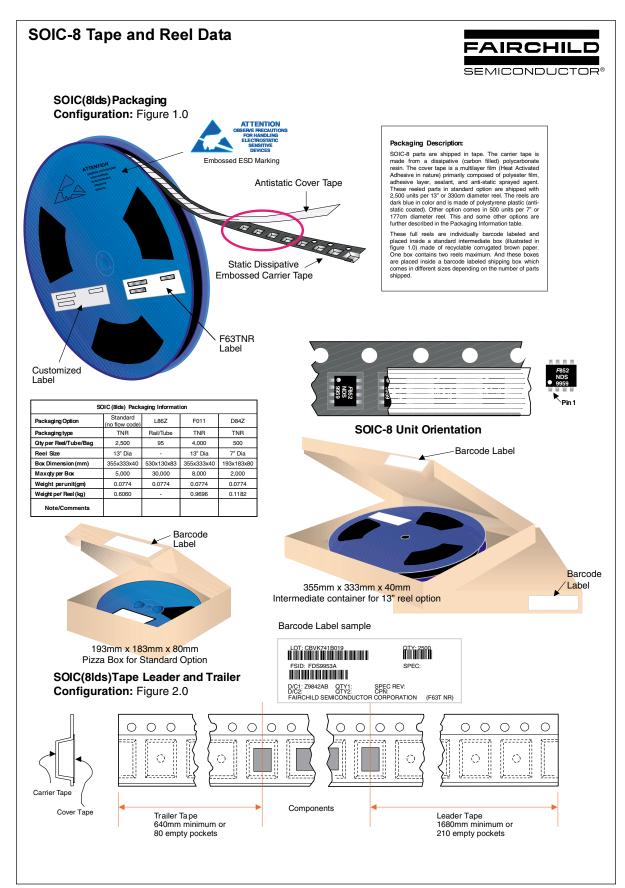


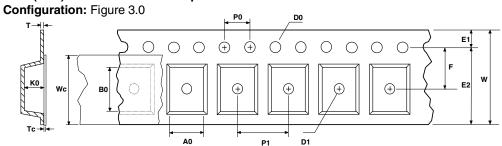
Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.





## SOIC(8lds) Embossed Carrier Tape



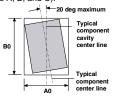


Dimensions are in millimeter														
Pkg type	Α0	В0	w	D0	D1	E1	E2	F	P1	P0	КО	т	Wc	Тс
SOIC(8lds) (12mm)	5.30 +/-0.10	6.50 +/-0.10	12.0 +/-0.3	1.55 +/-0.05	1.60 +/-0.10	1.75 +/-0.10	10.25 min	5.50 +/-0.05	8.0 +/-0.1	4.0 +/-0.1	2.1 +/-0.10	0.450 +/- 0.150	9.2 +/-0.3	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation



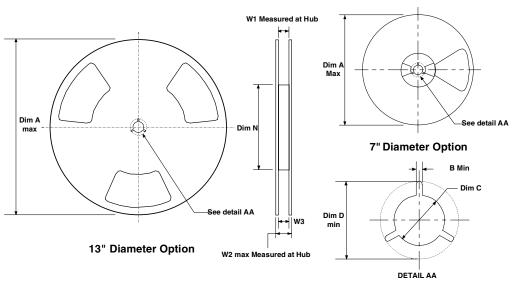
Sketch B (Top View)
Component Rotation



Sketch C (Top View)

Component lateral movement

## SOIC(8Ids) Reel Configuration: Figure 4.0

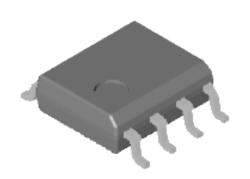


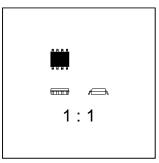
Dimensions are in inches and millimeters									
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)
12mm	7" Dia	7.00 177.8	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	2.165 55	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4
12mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	7.00 178	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4

# **SOIC-8 Package Dimensions**



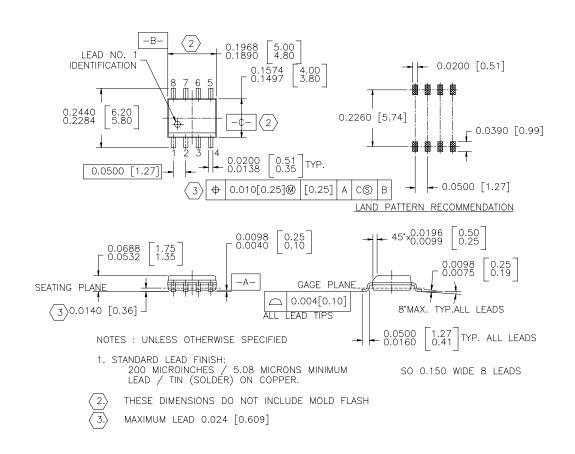
# SOIC-8 (FS PKG Code S1)





Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 0.0774



#### **TRADEMARKS**

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

 $VCX^{TM}$ SMART START™ ACEx™ FAST ® OPTOLOGIC™ FASTr™ STAR\*POWER™ Bottomless™ OPTOPLANAR™ Stealth™ CoolFET™  $\mathsf{PACMAN^{\mathsf{TM}}}$ FRFET™ SuperSOT™-3  $CROSSVOLT^{TM}$ GlobalOptoisolator™ **POPTM** SuperSOT™-6 GTO™ DenseTrench™ Power247™  $HiSeC^{\scriptscriptstyle\mathsf{TM}}$ SuperSOT™-8  $\mathsf{DOME}^\mathsf{TM}$ PowerTrench® SyncFET™ EcoSPARK™ ISOPLANAR™ QFET™ TinyLogic™ LittleFET™ E<sup>2</sup>CMOS<sup>TM</sup> QSTM TruTranslation™ EnSigna™ MicroFET™ QT Optoelectronics™ UHC™ FACT™ MicroPak™ Quiet Series™ UltraFET® FACT Quiet Series™ MICROWIRE™ SILENT SWITCHER®

STAR\*POWER is used under license

#### **DISCLAIMER**

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS. NOR THE RIGHTS OF OTHERS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the
- A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

### **PRODUCT STATUS DEFINITIONS**

#### **Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.